Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

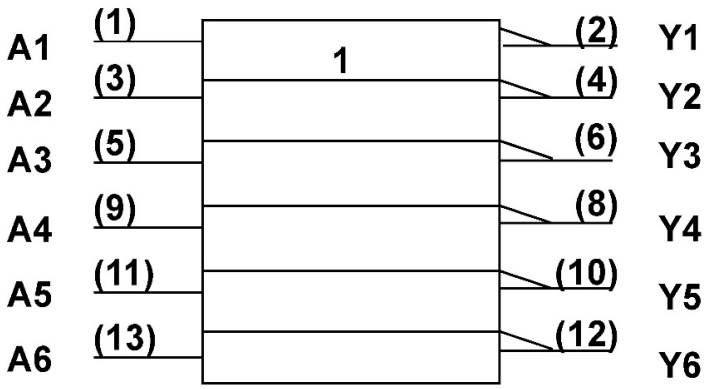
Features

- 0.6µm CRH CMOS Process
  - Latchup immune
- High speed
- Low power consumption
- Wide power supply operating range of 3.0V to 5.5V
- Available QML Q or V processes
- 14-lead flatpack
- UT54ACS14E - SMD 5962-96524
- UT54ACTS14E - SMD 5962-96525

Function Table

Input A	Output Y
H	L
L	H

Logic Symbol



Note:

1) Logic symbol in accordance with ANSI/IEEE standard 91-1984 and IEC Publication 617-12.

Description

The UT54ACS14E and the UT54ACTS14E are hex inverters with schmitt trigger inputs. The circuits perform the Boolean function $Y = \overline{A}$.

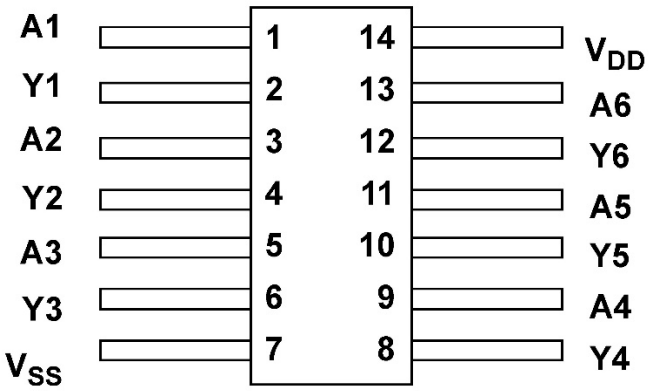
The devices are characterized over full HiRel temperature range of -55°C to +125°C.

CAES PIONEERING ADVANCED ELECTRONICS 4350 Centennial Blvd. | Colorado Springs CO 80907 USA | 1-800-645-8862 | cobhamaes.com

Hex Inverting Schmitt Triggers

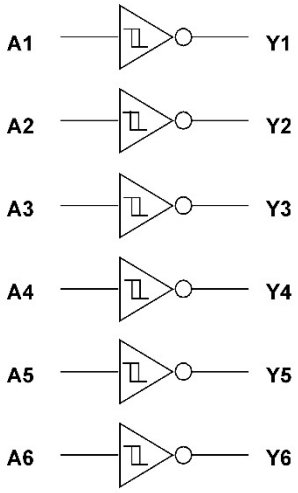
UT54ACS14E/UT54ACTS14E

Pinouts



14-Lead Flatpack
Top View

Logic Diagram



Operational Environment [1]

Parameter	Limit	Units
Total Dose	1.0E6	rads(Si)
SEU Threshold [2]	80	MeV-cm^2/mg
SEL Threshold	108	MeV-cm^2/mg
Neutron Fluence	1.0E14	n/cm^2

Notes:

1) Logic will not latchup during radiation exposure within the limits defined in the table.
2) Device storage elements are immune to SEU affects.

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

Absolute Maximum Ratings

Symbol	Parameter	Limit	Units
V_{DD}	Supply voltage	-0.3 to 7.0	V
$V_{I/O}$	Voltage any pin	-0.3 to V_{DD} +0.3	V
T_{STG}	Storage Temperature range	-65 to +150	°C
T_J	Maximum junction temperature	+175	°C
T_{LS}	Lead temperature (soldering 5 seconds)	+300	°C
Θ_{JC}	Thermal resistance junction to case	15 (ACS) 15.5 (ACTS)	°C/W
I_I	DC input current	±10	mA
P_D	Maximum package power dissipation permitted @ Tc= +125°C	3.3	W

Note:

1) Stresses outside the listed absolute maximum ratings may cause permanent damage to the device. This is a stress rating only, functional operation of the device at these or any other conditions beyond limits indicated in the operational sections is not recommended. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
2) Per MIL-STD-883, method 1012.1, Section 3.4.1, $P_D = (T_{j(max)} - T_{c(max)}) / \Theta_{jc}$

Recommended Operating Conditions

Symbol	Parameter	Limit	Units
V_{DD}	Supply voltage	3.0 to 5.5	V
V_{IN}	Input voltage any pin	0 to V_{DD}	V
T_C	Temperature range	-55 to +125	°C

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

DC Electrical Characteristics for the UT54ACS14E [7]

(V_{DD} = 3.0V to 5.5V; V_{SS} = 0V[6]; -55°C < T_C < +125°C)

Symbol	Description		Condition	MIN	MAX	Units
V_{T+}	Schmitt trigger positive-going threshold [1]		V_{DD} from 3.0V to 5.5V		0.7V_{DD}	V
V_{T-}	Schmitt trigger negative-going threshold [1]		V_{DD} from 3.0V to 5.5V	0.3V_{DD}		V
V_{H1}	Range of hysteresis (V_{T+} - V_{T-})		V_{DD} from 4.5V to 5.5V	0.6	1.5	V
V_{H2}	Range of hysteresis (V_{T+} - V_{T-})		V_{DD} from 3.0V to 3.6V	0.3	1.2	V
I_{IN}	Input leakage current		V_{IN} = V_{DD} or V_{SS}	-1	1	µA
V_{OL}	Low-level output voltage [3]		I_{OL} = 100µA V_{DD} from 3.0V to 5.5V		0.25	V
V_{OH}	High-level output voltage [3]		I_{OH} = -100µA V_{DD} from 3.0V to 5.5V	V_{DD} - 0.25		V
I_{OS1}	Short-circuit output current [2, 4]		V_O = V_{DD} and V_{SS} V_{DD} from 4.5V to 5.5V	-200	200	mA
I_{OS2}	Short-circuit output current [2, 4]		V_O = V_{DD} and V_{SS} V_{DD} from 3.0V to 3.6V	-100	100	mA
I_{OL1}	Low level output current [9] (sink)		V_{IN} = V_{DD} or V_{SS} V_{OL} = 0.4V V_{DD} from 4.5V to 5.5V	8		mA
I_{OL2}	Low level output current [9] (sink)		V_{IN} = V_{DD} or V_{SS} V_{OL} = 0.4V V_{DD} from 3.0V to 3.6V	6		mA
I_{OH1}	High level output current [9] (source)		V_{IN} = V_{DD} or V_{SS} V_{OH} = V_{DD} - 0.4V V_{DD} from 4.5V to 5.5V	-8		mA
I_{OH2}	High level output current [9] (source)		V_{IN} = V_{DD} or V_{SS} V_{OH} = V_{DD} - 0.4V V_{DD} from 3.0V to 3.6V	-6		mA
P_{total1}	Power dissipation [2, 8]		C_L = 50pF V_{DD} from 4.5V to 5.5V		1.8	mW/ MHz
P_{total2}	Power dissipation [2, 8]		C_L = 50pF V_{DD} from 3.0V to 3.6V		0.72	mW/ MHz
I_{DDQ}	Quiescent Supply Current	Pre-Rad All Device Types	V_{IN} = V_{DD} or V_{SS} V_{DD} = V_{DD} MAX		10	µA
		Post-Rad Device Type - 03			50	
		Post-Rad Device Type - 02			130	
C_{IN}	Input capacitance [5]		f = 1MHz, V_{DD} = 0		15	pF
C_{OUT}	Output capacitance [5]		f = 1MHz, V_{DD} = 0		15	pF

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

Notes:

1) Functional tests are conducted in accordance with MIL-STD-883 with the following input test conditions: $V_{IH} = V_{IH}(min) + 20\%, - 0\%$; $V_{IL} = V_{IL}(max) + 0\%, - 50\%$, as specified herein, for TTL, CMOS, or Schmitt compatible inputs. Devices may be tested using any input voltage within the above specified range, but are guaranteed to $V_{IH}(min)$ and $V_{IL}(max)$.
2) Supplied as a design limit but not guaranteed or tested.
3) Per MIL-PRF-38535, for current density ≤5.0E5 amps/cm^2, the maximum product of load capacitance (per output buffer) times frequency should not exceed 3,765pF/MHz.
4) Not more than one output may be shorted at a time for maximum duration of one second.
5) Capacitance measured for initial qualification and when design changes may affect the value. Capacitance is measured between the designated terminal and V_{SS} at frequency of 1MHz and a signal amplitude of 50mV rms maximum.
6) Maximum allowable relative shift equals 50mV.
7) Device type 02 is only offered with a TID tolerance guarantee of 3E5 rads(Si), and 1E6 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A and section 3.11.2. Device type 03 is only offered with a TID tolerance guarantee of 1E5 rads(Si), 3E5 rads(Si), and 5E5 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A.
8) Power dissipation specified per switching output.
9) Guaranteed by characterization, but not tested.

AC Electrical Characteristics for the UT54ACS14E [2]

(V_{DD} = 3.0V to 5.5V; V_{SS} = 0V [1], -55°C < T_C < +125°C)

Symbol	Parameter	Condition	V_{DD}	Minimum	Maximum	Unit
t_{PHL}	Input to Yn	C_L = 50pF	3.0V to 3.6V	2	18	ns
			4.5V to 5.5V	2	14	ns
t_{PLH}	Input to Yn	C_L = 50pF	3.0V to 3.6V	2	17	ns
			4.5V to 5.5V	2	13	ns
t_{PHL}	Input to Yn	C_L = 30pF	3.0V to 3.6V	2	14	ns
			4.5V to 5.5V	2	10	ns
t_{PLH}	Input to Yn	C_L = 30pF	3.0V to 3.6V	2	13	ns
			4.5V to 5.5V	2	9	ns

Notes:

1) Maximum allowable relative shift equals 50mV.
2) Device type 02 is only offered with a TID tolerance guarantee of 3E5 rads(Si), and 1E6 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A and section 3.11.2. Device type 03 is only offered with a TID tolerance guarantee of 1E5 rads(Si), 3E5 rads(Si), and 5E5 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A.

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

DC Electrical Characteristics for the UT54ACTS14E [7]

(V_{DD} = 3.0V to 5.5V; V_{SS} = 0V[6]; -55°C < T_C < +125°C)

Symbol	Description		Condition	MIN	MAX	Unit
V_{T+1}	Schmitt trigger positive-going threshold [1]		V_{DD} from 4.5V to 5.5V		2.25	V
V_{T+2}	Schmitt trigger positive-going threshold [1]		V_{DD} from 3.0V to 3.6V		2.0	V
V_{T-1}	Schmitt trigger negative-going threshold [1]		V_{DD} from 4.5V to 5.5V	0.5		V
V_{T-2}	Schmitt trigger negative-going threshold [1]		V_{DD} from 3.0V to 3.6V	0.5		V
V_{H1}	Range of hysteresis (V_{T+1} - V_{T-1})		V_{DD} from 4.5V to 5.0V	0.4	1.5	V
V_{H2}	Range of hysteresis (V_{T+2} - V_{T-2})		V_{DD} from 3.0V to 3.6V	0.2	1.2	V
I_{IN}	Input leakage current		V_{IN} = V_{DD} or V_{SS}	-1	1	µA
V_{OL1}	Low-level output voltage [3]		I_{OL} = 8mA V_{DD} from 4.5V to 5.5V		0.4	V
V_{OL2}	Low-level output voltage [3]		I_{OL} = 6mA V_{DD} from 3.0V to 3.6V		0.4	V
V_{OH1}	High-level output voltage [3]		I_{OH} = -8mA V_{DD} from 4.5V to 5.5V	0.7V_{DD}		V
V_{OH2}	High-level output voltage [3]		I_{OH} = -6mA V_{DD} from 3.0V to 3.6V	2.4		V
I_{OS1}	Short-circuit output current [2, 4]		V_O = V_{DD} or V_{SS} V_{DD} from 4.5V to 5.5V	-200	200	mA
I_{OS1}	Short-circuit output current [2, 4]		V_O = V_{DD} or V_{SS} V_{DD} from 3.0V to 3.6V	-100	100	mA
I_{OL1}	Low level output current [9]		V_{IN} = V_{DD} or V_{SS} V_{OL} = 0.4V V_{DD} from 4.5V to 5.5V	8		mA
I_{OL2}	Low level output current [9]		V_{IN} = V_{DD} or V_{SS} V_{OL} = 0.4V V_{DD} from 3.0V to 3.6V	6		mA
I_{OH1}	High level output current [9]		V_{IN} = V_{DD} or V_{SS} V_{OH} = V_{DD}-0.4V, V_{DD} from 4.5V to 5.5V	-8		mA
I_{OH2}	High level output current [9]		V_{IN} = V_{DD} or V_{SS} V_{OH} = V_{DD} - 0.4V V_{DD} from 3.0V to 3.6V	-6		mA
P_{total1}	Power dissipation [2, 8]		C_L = 50pF V_{DD} from 4.5V to 5.5V		1.3	mW/ MHz
P_{total2}	Power dissipation [2, 8]		C_L = 50pF V_{DD} from 3.0V to 3.6V		0.5	mW/ MHz
I_{DDQ}	Quiescent Supply Current	Pre-Rad All Device Types	V_{IN} = V_{DD} or V_{SS} V_{DD} = V_{DD} MAX		10	µA
		Post-Rad Device Type - 03			50	
		Post-Rad Device Type - 02			130	

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

Symbol	Description	Condition	MAX	MIN	Unit
ΔI_{DDQ}	Quiescent Supply Current Delta	For input under test $V_{IN} = V_{DD}$ -2.1V For all other inputs $V_{IN} = V_{DD}$ or V_{SS} V_{DD} = 5.5V		3.1	mA
C_{IN}	Input capacitance [5]	f = 1MHz, V_{DD} = 0		15	pF
C_{OUT}	Output capacitance [5]	f = 1MHz, V_{DD} = 0		15	pF

Notes:

1) Functional tests are conducted in accordance with MIL-STD-883 with the following input test conditions: $V_{IH} = V_{IH}(min)$ + 20%, - 0%; $V_{IL} = V_{IL}(max)$ + 0%, - 50%, as specified herein, for TTL, CMOS, or Schmitt compatible inputs. Devices may be tested using any input voltage within the above specified range, but are guaranteed to $V_{IH}(min)$ and $V_{IL}(max)$.
2) Supplied as a design limit but not guaranteed or tested.
3) Per MIL-PRF-38535, for current density ≤5.0E5 amps/cm^2, the maximum product of load capacitance (per output buffer) times frequency should not exceed 3,765pF/MHz.
4) Not more than one output may be shorted at a time for maximum duration of one second.
5) Capacitance measured for initial qualification and when design changes may affect the value. Capacitance is measured between the designated terminal and V_{SS} at frequency of 1MHz and a signal amplitude of 50mV rms maximum.
6) Maximum allowable relative shift equals 50mV.
7) Device type 02 is only offered with a TID tolerance guarantee of 3E5 rads(Si), and 1E6 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A and section 3.11.2. Device type 03 is only offered with a TID tolerance guarantee of 1E5 rads(Si), 3E5 rads(Si), and 5E5 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A.
8) Power dissipation specified per switching output.
9) Guaranteed by characterization, but not tested.

AC Electrical Characteristics for the UT54ACTS14E [2]

(V_{DD} = 3.0V to 5.5V; V_{SS} = 0V [1], -55°C < T_C < +125°C)

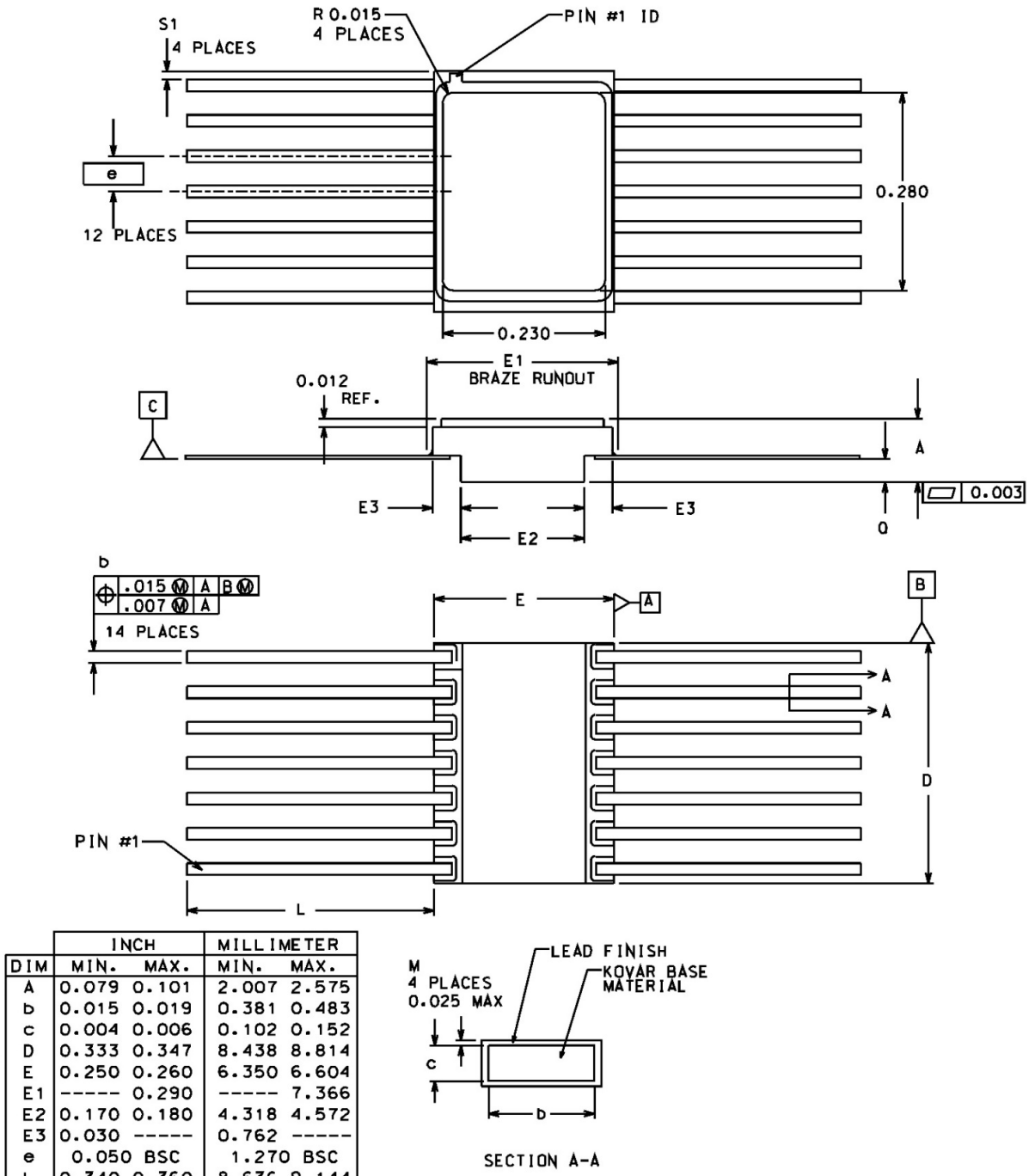
Symbol	Parameter	Condition	V_{DD}	Minimum	Maximum	Unit
t_{PHL}	Input to Yn	C_L = 50pF	3.0V to 3.6V	2	20	ns
			4.5V to 5.5V	2	9	
t_{PLH}	Input to Yn	C_L = 50pF	3.0V to 3.6V	3	20	ns
			4.5V to 5.5V	2	12	

Notes:

1) Maximum allowable relative shift equals 50mV.
2) Device type 02 is only offered with a TID tolerance guarantee of 3E5 rads(Si), and 1E6 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A and section 3.11.2. Device type 03 is only offered with a TID tolerance guarantee of 1E5 rads(Si), 3E5 rads(Si), and 5E5 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A.

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E



DIM	INCH MIN.	INCH MAX.	MILLIMETER MIN.	MILLIMETER MAX.
A	0.079	0.101	2.007	2.575
b	0.015	0.019	0.381	0.483
c	0.004	0.006	0.102	0.152
D	0.333	0.347	8.438	8.814
E	0.250	0.260	6.350	6.604
E1	-----	0.290	-----	7.366
E2	0.170	0.180	4.318	4.572
E3	0.030	-----	0.762	-----
e	0.050 BSC		1.270 BSC	
L	0.340	0.360	8.636	9.144
Q	0.026	-----	0.660	-----
S1	0.005	-----	0.127	-----

Figure 1: 14-lead Flatpack

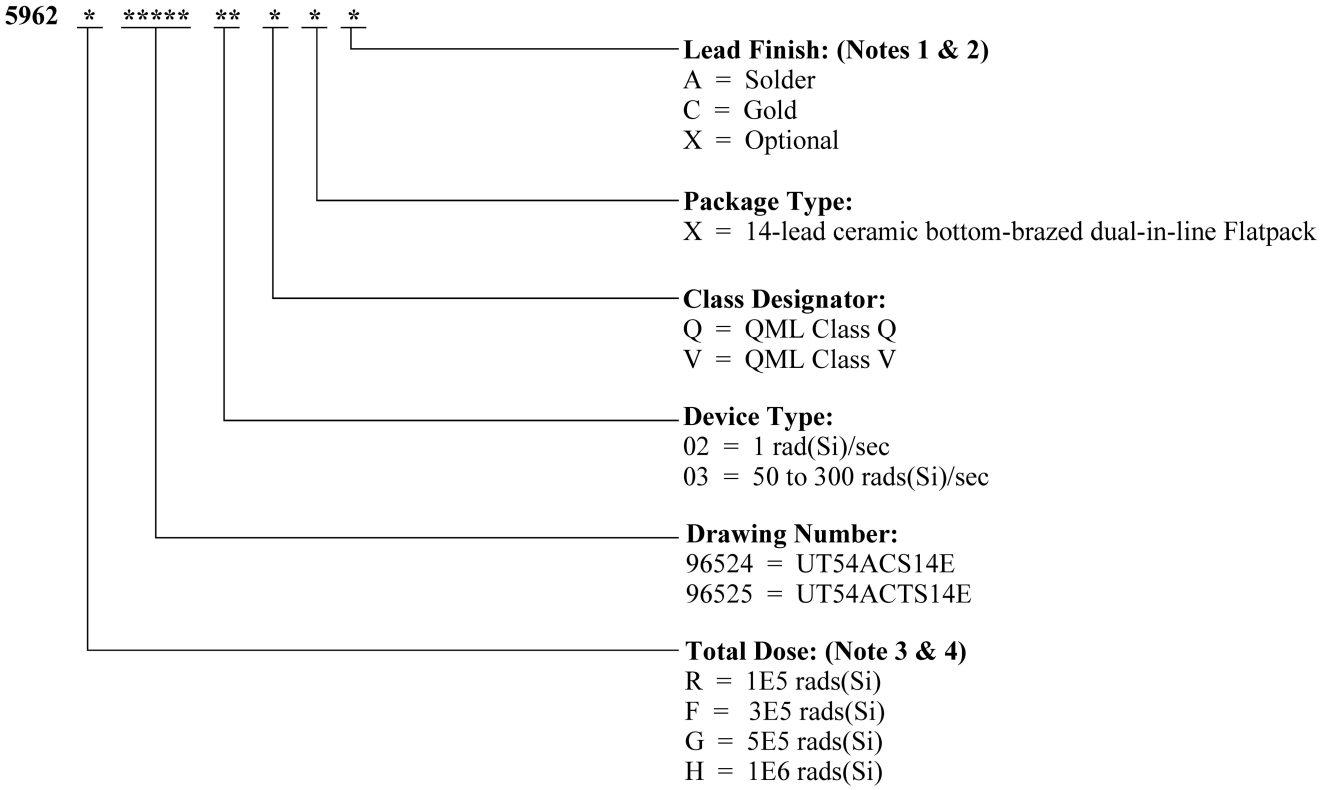
Notes

1) All exposed metallized areas are gold plated over electroplated nickel per MIL-PRF-38535.
2) The lid is electrically connected to V_{SS}.
3) Lead finishes are in accordance with MIL-PRF-38535.
4) Dimension symbol is in accordance with MIL-PRF-38533.
5) Lead position and colanarity are not measured.

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

UT54ACS14E/UT54ACTS14E: SMD



Notes:

1) Lead finish (A,C, or X) must be specified.
2) If an "X" is specified when ordering, part marking will match the lead finish and will be either "A" (solder) or "C" (gold).
3) Total dose radiation must be specified when ordering. QML-2 and V is not available without radiation testing. For prototyping inquiries, contact factory.
4) Device type 02 is only offered with a TID tolerance guarantee of 3E5 rads(Si) or 1E6 rads(Si) and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A and section 3.11.2. Device type 03 is only offered with a TID tolerance guarantee of 1E5 rads(Si), 3E5 rads(Si), and 5E5 rads(Si), and is tested in accordance with MIL-STD-883 Test Method 1019 Condition A.

Revision Date	Description of Change	Author
10-17	Page 4 edited PTOTAL2 Pages 4 and 6 edited IDDQ Page 5 AC Electricals Added new CAES Data Sheet template to the document.	RT
1-18	Updates to reflect current SMD	**RT**

DATASHEET

RELEASED 1/18

Hex Inverting Schmitt Triggers

UT54ACS14E/UT54ACTS14E

Datasheet Definitions

	DEFINITION
Advanced Datasheet	CAES reserves the right to make changes to any products and services described herein at any time without notice. The product is still in the development stage and the datasheet **is subject to change**. Specifications can be **TBD** and the part package and pinout are **not final**.
Preliminary Datasheet	CAES reserves the right to make changes to any products and services described herein at any time without notice. The product is in the characterization stage and prototypes are available.
Datasheet	Product is in production and any changes to the product and services described herein will follow a formal customer notification process for form, fit or function changes.

The following United States (U.S.) Department of Commerce statement shall be applicable if these commodities, technology, or software are exported from the U.S.: These commodities, technology, or software were exported from the United States in accordance with the Export Administration Regulations. Diversion contrary to U.S. law is prohibited.